

Smart high-side NMOS-power switch

ITS4300S-SJ-D



Features

- CMOS compatible input
- Switching all types of resistive, inductive and capacitive loads
- Fast demagnetization of inductive loads
- Very low standby current
- Optimized Electromagnetic Compatibility (EMC)
- Open drain diagnostic output for overtemperature and short circuit
- Open load detection in OFF-state with external resistor
- Overload protection
- **Current limitation**
- Short circuit protection
- Thermal shutdown with restart
- Overvoltage protection (including load dump)
- Reverse battery protection with external resistor
- Loss of GND and loss of Vbb protection
- Electrostatic Discharge Protection (ESD)
- Green Product (RoHS compliant)

Applications

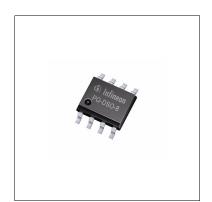
- All types of resistive, inductive and capacitive loads
- Power switch for 12V and 24V DC applications with CMOS compatible control interface
- Driver for electromagnetic relays
- Power management for high-side-switching with low current consumption in OFF-mode

Product Validation

Qualified for industrial applications according to the relevant tests of JEDEC.

Description

The ITS4300S-SJ-D is a protected single channel Smart High-Side NMOS-Power Switch in a PG-DSO-8 package with charge pump, CMOS compatible input and diagnostic feedback.





Product summary Table 1

Parameter	Symbol	Values	
Overvoltage protection	V_{SAZmin}	41 V	
Operating voltage range	V_{S}	5V < V _S < 34V	
On-state resistance	R_{DSON}	typ. 300 mΩ	
Nominal load current	I _{L(nom)}	0.4 A	
Operating temperature range	T _i	-40°C to 125°C	
Stand-by current	I _{SSTB}	26 μΑ	

Туре	Package	Marking
ITS4300S-SJ-D	PG-DSO-8	1300SD



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Block diagram and terms

Block diagram and terms 1

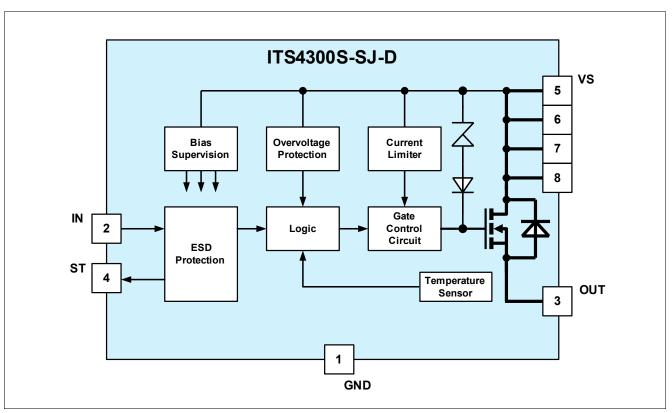
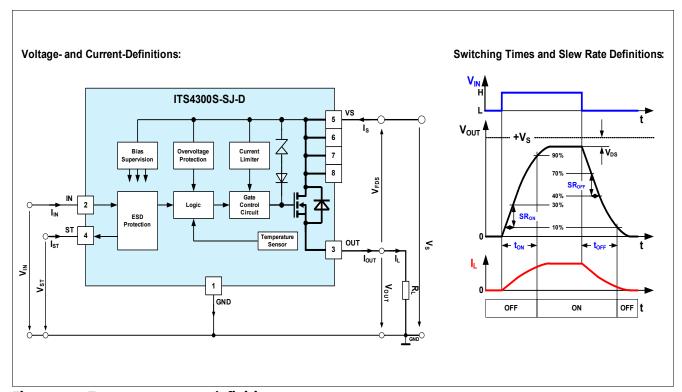


Figure 1 **Block diagram**



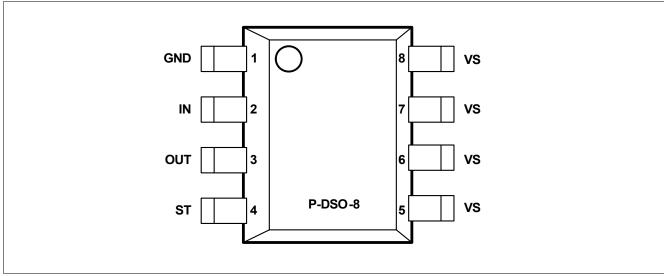
Terms - parameter definition Figure 2



Pin configuration

Pin configuration 2

Pin assignment 2.1



Pin configuration top view, PG-DSO-8 Figure 3

2.2 Pin definitions and functions

Pin	Symbol	Function
1	GND	Logic ground
2	IN	Input, controls the power switch; the powerswitch is ON when high
3	OUT	Output to the load
4	ST	Status flag; diagnosis feedback; NMOS open drain
5, 6, 7, 8	VS	Supply voltage (design the wiring for the maximum short circuit current and also for low thermal resistance)



General product characteristics

General product characteristics 3

3.1 Absolute maximum ratings

Absolute maximum ratings $^{1)}$ at $T_{\rm j}$ = 25°C unless otherwise specified. Currents flowing into Table 2 the device unless otherwise specified in chapter "Block Diagram and Terms"

Parameter	Symbol		Value	s	Unit	Note or	Number
		Min.	Тур.	Max.		Test Condition	
Supply voltage VS	1	1			T.		
Voltage	V_{S}	-	-	40	٧	-	4.1.1
Voltage for short circuit protection	$V_{\rm SSC}$	_	_	28	٧	_	4.1.2
Output stage OUT			<u> </u>				
Output current; (short circuit current see electrical characteristics)	I _{OUT}	_	-	self limited	A	-	4.1.3
Input IN							
Voltage	V_{IN}	-10	_	16	V	_	4.1.4
Current	I _{IN}	-5	_	5	mA	_	4.1.5
Status ST							
Current	I _{ST}	-5	-	5	mA	-	4.1.6
Temperatures	•	•	·	•	•		•
Junction temperature	$T_{\rm j}$	-40	-	125	°C	_	4.1.7
Storage temperature	$T_{\rm stg}$	-55	_	125	°C	_	4.1.8
Power dissipation							
Ta = 25 °C ²⁾	P _{tot}	-	_	1.4	W	-	4.1.9
Inductive load switch-off energy d	issipatio	n					
$T_{\rm j}$ = 125 °C; $V_{\rm S}$ = 13.5V; $I_{\rm L}$ = 0.3A ³⁾	E _{AS}	-	-	800	mJ	single pulse	4.1.10
ESD susceptibility							
ESD susceptibility (input pin IN)	V_{ESD}	-1	-	1	kV	HBM ⁴⁾	4.1.11
ESD susceptibility (output pin OUT)	V _{ESD}	-6	-	6	kV	HBM ⁴⁾	4.1.13
ESD susceptibility (all other pins)	V _{ESD}	-3	_	3	kV	HBM ⁴⁾	4.1.12

¹⁾ Not subject to production test, specified by design

Note:

Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Integrated protection functions are designed to prevent IC destruction under fault conditions described in the data sheet. Fault conditions are considered as "outside" the normal operating range. Protection functions are neither designed for continuous nor repetitive operation.

²⁾ Device on 50mm*50mm*1.5mm epoxy PCB FR4 with 6 cm2 (one layer, 70mm thick) copper area for Vbb connection. PCB is vertical without blown air

³⁾ Not subject to production test, specified by design

⁴⁾ ESD susceptibility HBM according to ANSI/ESDA/JEDEC J001 (1.5k Ω , 100pF).



General product characteristics

3.2 **Functional range**

Table 3 **Functional range**

Parameter	Symbol Values			Unit	Note or	Number	
		Min.	Тур.	Max.		Test Condition	
Nominal operating voltage	V _s	5	_	34	٧	V _s increasing	4.2.1

Note:

Within the functional range the IC operates as described in the circuit description. The electrical characteristics are specified within the conditions given in the related electrical characteristics table.

Thermal resistance 3.3

Note:

This thermal data was generated in accordance with JEDEC JESD51 standards. For more information, go to www.jedec.org.

Thermal resistance1) Table 4

Parameter	Symbol		Value	s	Unit	Note or	Number
		Min.	Тур.	Max.		Test Condition	
Thermal resistance - junction to pin5	R _{thj-pin5}	-	34.5	_	K/W	-	4.3.1
Thermal resistance - junction to ambient - 1s0p, minimal footprint	R _{thJA_1s0p}	-	145	_	K/W	2)	4.3.2
Thermal resistance - junction to ambient - 1s0p, 300mm ²	R _{thJA_1s0p_300mm}	-	89	-	K/W	3)	4.3.3
Thermal resistance - junction to ambient - 1s0p, 600mm ²	R _{thJA_1s0p_600mm}	-	78	-	K/W	4)	4.3.4
Thermal resistance - junction to ambient - 2s2p	R _{thJA_2s2p}	-	85	_	K/W	5)	4.3.5
Thermal resistance - junction to ambient with thermal vias - 2s2p	R _{thJA_2s2p}	-	60.4	_	K/W	6)	4.3.6

¹⁾ Not subject to production test, specified by design

- Specified R_{thJA} value is according to Jedec JESD51-3 at natural convection on FR4 1s0p board, footprint; the product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 1x 70μm Cu.
- 3) Specified R_{th IA} value is according to Jedec JESD51-3 at natural convection on FR4 1s0p board, Cu, 300mm²; the Product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 1x 70μm Cu.
- 4) Specified R_{th IA} value is according to Jedec JESD51-3 at natural convection on FR4 1s0p board, 600mm²; the product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 1x 70μm Cu.
- Specified R_{thJA} value is according to Jedec JESD51-2,-5,-7 at natural convection on FR4 2s2p board; the product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 2 inner copper layers (2 x 70μm Cu, 2 x 35μm Cu).
- 6) Specified $R_{th,IA}$ value is according to Jedec JESD51-2,-5,-7 at natural convection on FR4 2s2p board with two thermal vias; the Product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 2 inner copper layers (2 x 70 µm Cu, 2 x 35µm Cu. The diameter of the two vias are equal 0.3mm and have a plating of 25um with a copper heatsink area of 3mm x 2mm). JEDEC51-7: The two plated-through hole vias should have a solder land of no less than 1.25 mm diameter with a drill hole of no less than 0.85 mm diameter.



Electrical Characteristics

Electrical Characteristics 4

 V_s =13.5V; T_i = -40°C to +125°C; all voltages with respect to ground. Currents flowing into the Table 5 device unless otherwise specified in chapter "Block Diagram and Terms". Typical values at $V_s = 13.5V, T_i = 25^{\circ}C$

Parameter	Symbol	Values			Unit	Note or	Number
		Min.	Тур.	Max.		Test Condition	
Powerstage	1	1	ı		l		1
NMOS ON resistance	R _{DSON}	_	300	400	mΩ	$I_{OUT} = 0.3A; T_j = 25$ °C; 9V < V_S < 34V; $V_{IN} = 5$ V	5.0.1
NMOS ON resistance	R_{DSON}	-	480	600	mΩ	I_{OUT} = 0.3A; T_{j} = 125°C; 9V < V_{S} < 34V; V_{IN} = 5V	5.0.2
Nominal load current; device on PCB ¹⁾	I _{LNOM}	0.4	-	-	А	$T_{\text{pin5}} = 85^{\circ}\text{C}$	5.0.3
Timings of power stages ²⁾			•	•			
Turn ON time (to 90% of V_{out}); L to H transition of V_{IN}	t _{ON}	-	-	140	μs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 47 Ω	5.0.4
Turn OFF time (to 10% of V_{out}); H to L transition of V_{IN}	t _{OFF}	-	-	170	μs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 47 Ω	5.0.5
ON-slew rate; ΔV _{OUT} / Δt; (10 to 30% of V _{out}); L to H transition of V _{IN}	SR _{ON}	-	-	2.0	V/µs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 47 Ω	5.0.6
OFF-slew rate; $\Delta V_{\rm OUT}/\Delta t$; (70 to 40% of $V_{\rm out}$); H to L transition of $V_{\rm IN}$	SR _{OFF}	_	-	2.0	V / μs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 47 Ω	5.0.7
Under voltage lockout (charge	pump start	-stop-ı	restart)				
Supply undervoltage; charge pump stop voltage	V _{SUV}	_	-	5.5	V	$V_{\rm S}$ decreasing	5.0.8
Supply startup voltage; Charge pump restart voltage	V _{SSU}	_	-	5.5	V	V _S increasing	5.0.9
Current consumption	·						
Operating current	I _{GND}	_	-	1.3	mA	V _{IN} = 5V	5.0.10
Standby current	I _{SSTB}	-	-	26	μΑ	$V_{\rm IN}$ = 0V; $V_{\rm OUT}$ = 0V -40°C < $T_{\rm j}$ < 85°C	5.0.11
Standby current	I _{SSTB}	_	_	26	μΑ	$V_{\rm IN} = 0V; T_{\rm j} = 125^{\circ}C$	5.0.12
Output leakage current	I _{OUTLK}	_	_	12	μΑ	$V_{\rm IN}$ = 0V; $V_{\rm OUT}$ = 0V	5.0.13
Protection functions ³⁾	•	•	'	'	'		
Initial peak short circuit current limit	I _{LSCP}	-	-	2	А	$T_{\rm j}$ = -40°C; $V_{\rm S}$ = 20V; $V_{\rm IN}$ = 5.0V	5.0.14



Electrical Characteristics

Table 5 $V_{\rm S}$ =13.5V; $T_{\rm j}$ = -40°C to +125°C; all voltages with respect to ground. Currents flowing into the device unless otherwise specified in chapter "Block Diagram and Terms". Typical values at $V_{\rm s}$ = 13.5V, $T_{\rm j}$ = 25°C

Parameter	Symbol		Values	5	Unit	Note or	Number	
		Min.	Тур.	Max.		Test Condition		
Initial peak short circuit current limit	I _{LSCP}	-	1.2	-	А	$T_{\rm j} = 25$ °C; $V_{\rm S} = 20$ V; $V_{\rm IN} = 5.0$ V	5.0.15	
Initial peak short circuit current limit	I _{LSCP}	0.4	-	-	А	$T_{\rm j}$ =125°C; $V_{\rm S}$ = 20V; $V_{\rm IN}$ = 5.0V	5.0.16	
Repetitive short circuit current limit $T_j = T_{jTrip}$; see timing diagrams	I _{LSCR}	_	1	_	A	V _{IN} = 5.0V	5.0.17	
Output clamp at $V_{OUT} = V_S - V_{DSCL}$ (inductive load switch off)	$V_{\rm DSCL}$	41	47	-	V	I _S = 4mA	5.0.18	
Overvoltage protection	V_{SAZ}	41	-	-	V	I _S = 4mA	5.0.19	
$V_{\text{OUT}} = V_{\text{S}} - V_{\text{ONCL}}$								
Thermal overload	$T_{\rm jTrip}$	150	_	-	°C		5.0.20	
trip temperature								
Thermal hysteresis	T_{HYS}	-	10	-	K		5.0.21	
Reverse Battery ⁴⁾								
Continuous reverse battery voltage	V_{SREV}	- 32	-	-	V		5.0.22	
Forward voltage of the drain- source reverse diode	V _{FDS}	_	600	-	mV	$I_{FDS} = 200 \text{mA};$ $V_{IN} = 0 \text{V}; T_{i} = 125 ^{\circ}\text{C}$	5.0.23	
Input interface; pin IN						,		
Input turn-ON voltage (logic input high-level)	V_{INON}	2.2	-	-	V		5.0.24	
Input turn-OFF voltage (logic input low-level)	V_{INOFF}	-	-	0.8	V		5.0.25	
Input threshold hysteresis	V _{INHYS}	_	0.3	_	٧		5.0.26	
Off state input current	I _{INOFF}	1	_	30	μΑ	$V_{IN} = 0.7V$	5.0.27	
On state input current	I _{INON}	1	_	30	μΑ	V _{IN} = 5.0V	5.0.28	
Input resistance	R _{IN}	1.5	3.5	5.0	kΩ		5.0.29	
Status output (NMOS open drain								
Status output zener voltage	V _{STZ}	5.4	6.1	6.8	٧	I _{ST} = 1.6mA	5.0.30	
Status output low voltage	V _{STLO}	_	-	0.4	V	$I_{ST} = 1.6 \text{mA}$ $T_i < 25 ^{\circ}\text{C}$	5.0.31	
Status output low voltage	V _{STLO}	_	_	0.6	V	$I_{ST} = 1.6 \text{mA}$ $T_i < 125^{\circ}\text{C}$	5.0.32	
Status leakage current	I _{STLK}	_	_	2	μΑ	$V_{ST} = 5V$ $T_i < 105^{\circ}C$	5.0.33	
Status invalid time after positive input slope ⁵⁾	$t_{\sf dP}$	_	300	600	μs	$V_{\rm S} = 20 \rm V$	5.0.34	



Electrical Characteristics

Table 5 V_s =13.5V; T_j = -40°C to +125°C; all voltages with respect to ground. Currents flowing into the device unless otherwise specified in chapter "Block Diagram and Terms". Typical values at V_s = 13.5V, T_i = 25°C

Parameter	Symbol	Values			Unit	Note or	Number
		Min.	Тур.	Max.		Test Condition	
Diagnostic characteristics	<u>'</u>	1					
Short circuit detection voltage	V_{OUTSC}	-	2.8	_	V		5.0.35
Open load detection voltage ⁶⁾	V _{OUTOL}	_	3	-	V		5.0.36
Open load detection current ⁷⁾ (included in standby current)	I _{OUTOL}	_	5	-	μΑ	V _{OUT} = 4V	5.0.37

- 1) Device on 50mm x 50mm x 1,5mm epoxy FR4 PCB with 6cm² (one layer copper 70um thick) copper area for supply voltage connection. PCB in vertical position without blown air.
- 2) Timing values only with high slewrate input signal; otherwise slower.
- 3) Integrated protection functions are designed to prevent IC destruction under fault conditions described in the data sheet. Fault conditions are considered as "outside" normal operating range. Protection functions are not designed for continuous repetitive operation.
- 4) Requires a 150W resistor in GND connection. The reverse load current trough the intrinsic drain-source diode of the power-MOS has to be limited by the connected load. Power dissipation is higher compared to normal operation due to the voltage drop across the drain-source diode. The temperature protection is not functional during reverse current operation! Input current has to be limited (see max ratings).
- 5) No delay time after overtemparature switch off and short circuit in on-state.
- 6) External pull up resistor required for open load detection in off state.
- 7) External pull up resistor required for open load detection in off state.

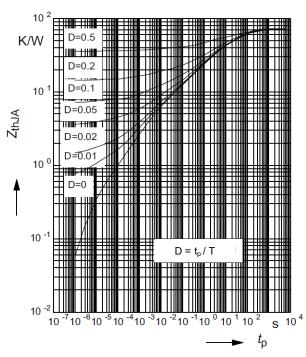


Typical performance graphs

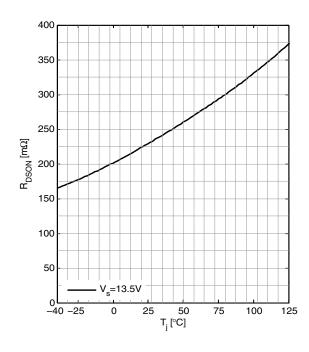
Typical performance graphs 5

Typical performance characteristics

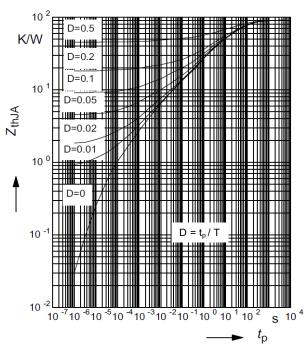
Transient thermal impedance Z_{thJA} versus pulse time t_p @ 6cm² heatsink area



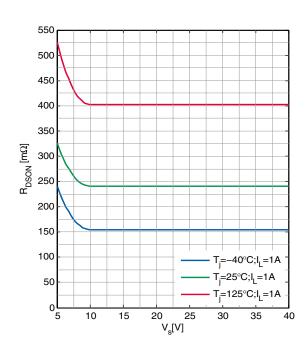
On-resistance R_{DSON} versus junction temperature Ti



Transient thermal impedance Z_{thJA} versus pulse time t_p @ minimum footprint



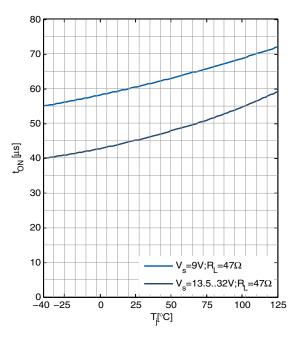
On-resistance R_{DSON} versus supply voltage Vs



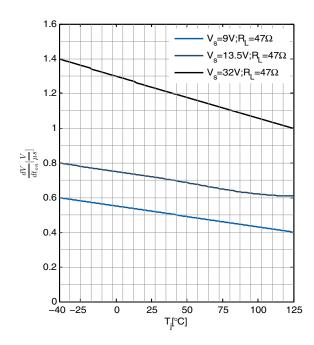
Typical performance graphs

Typical performance characteristics

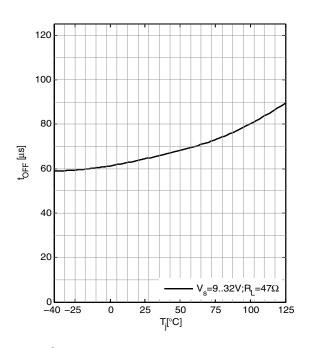
Switch ON time $t_{\rm ON}$ versus junction temperature T_i



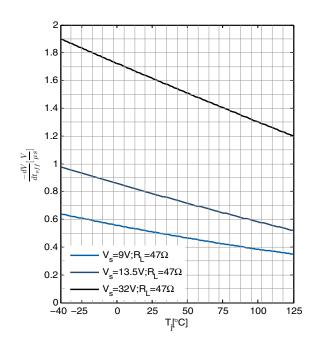
ON slewrate SR_{ON} versus junction temperature T_i



Switch OFF time $t_{\rm OFF}$ versus junction temperature T_i



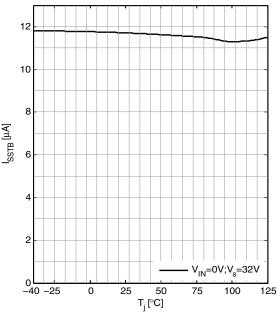
OFF slewrate *SR***OFF versus** junction temperature T_i



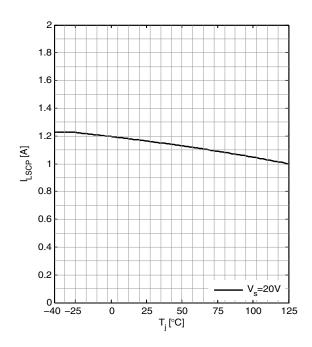
Typical performance graphs

Typical performance characteristics

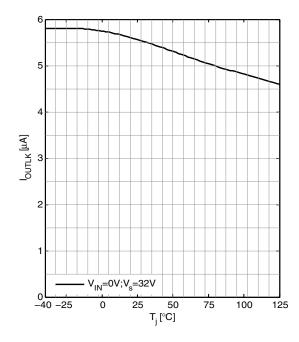
Standby current $I_{\rm SSTB}$ versus junction temperature $T_{\rm j}$



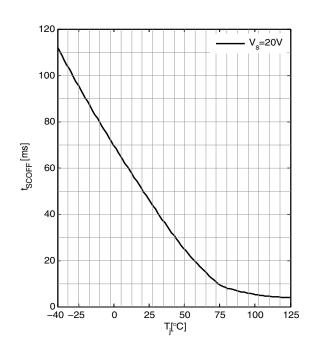
Initial peak short circuit current limit $I_{\rm LSCP}$ versus junction temperature T_i



Output leakage current $I_{\rm OUTLK}$ versus junction temperature T_i



Initial short circuit shutdown time $t_{\mathtt{SCOFF}}$ versus junction temperature T_i

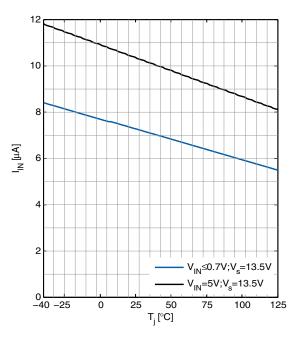




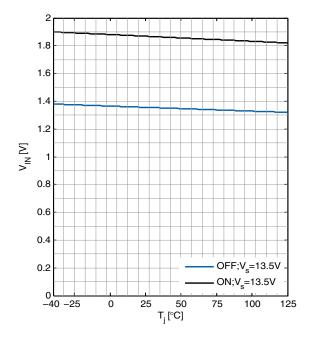
Typical performance graphs

Typical performance characteristics

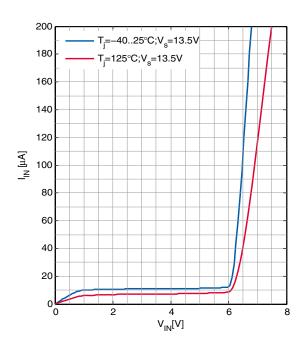
Input current consumption I_{IN} versus junction temperature T_i



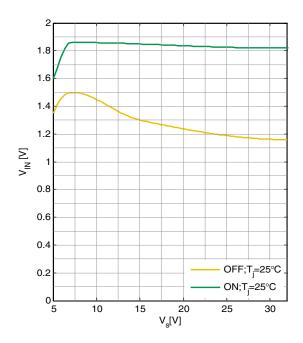
Input threshold voltage $V_{\mathrm{INH,L}}$ versus junction temperature $T_{\rm j}$



Input current consumption I_{IN} versus input voltage V_{IN}



Input threshold voltage $V_{\rm INH,L}$ versus supply voltage V_S

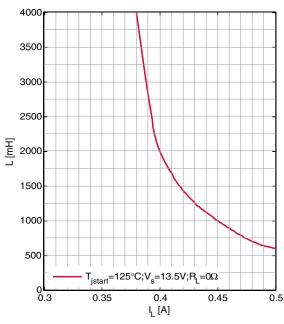




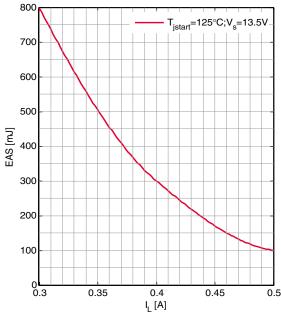
Typical performance graphs

Typical performance characteristics

Max. allowable load inductance L versus load current I_L



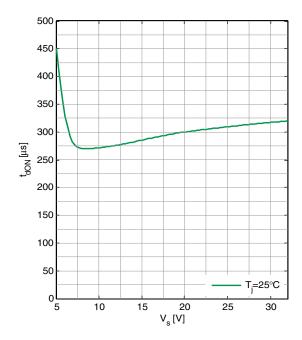
700 600



Max. allowable inductive single pulse switch-off

Energy E_{AS} versus load current I_{L}

Status delay time $t_{\rm dP}$ versus supply voltage V_s





6 Application information

6.1 Application diagram

The following information is given as a hint for the implementation of the device only and shall not be regarded as a description or warranty for a certain functionality, condition or quality of the device.

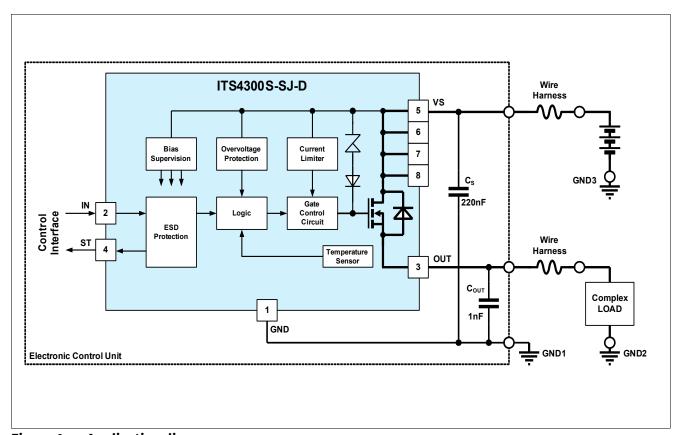


Figure 4 Application diagram

The ITS4300S-SJ-D can be connected directly to a supply network. It is recommended to place a ceramic capacitor (e.g. $C_S = 220$ nF) between supply and GND to avoid line disturbances. Wire harness inductors/resistors are sketched in the application circuit above.

The complex load (resistive, capacitive or inductive) must be connected to the output pin OUT.

A built-in current limit protects the device against destruction.

The ITS4300S-SJ-D can be switched on and off with standard logic ground related logic signal at pin IN.

In standby mode (IN=L) the ITS4300S-SJ-D is deactivated with very low current consumption.

The output voltage slope is controlled during on and off transition to minimize emissions. Only a small ceramic capacitor COUT=1nF is recommended to attenuate RF noise.

In the following chapters the main features, some typical waverforms and the protection behavior of the ITS4300S-SJ-D is shown. For further details please refer to application notes on the Infineon homepage.

Smart high-side NMOS-power switch

ITS4300S-SJ-D



Application information

Diagnosis description 6.2

For diagnostic purpose the device provides a digital output pin ST in order to indicate fault conditions.

The status output (ST) of the ITS4300S-SJ-D is a high voltage open drain output.

In "normal" operation mode the NMOS open drain transistor is switched OFF.

The following truth table defines the status output.

Table 6 Truth table of diagnosis feature

Device operation	IN	OUT	ST	Comment
Normal operation	Н	Н	Н	
Short circuit to GND	L	L	Н	No diagnosis
Short circuit to GND	Н	L	L	OUT=L: $V_{\text{OUT}} < V_{\text{OUTSC}}$; Short circuit detection voltage; typ 2.8V
Short circuit to V _S (in OFF state)	L	Н	L	
Short circuit to V _S (in ON state)	Н	Н	Н	No diagnosis
Overload	L	L	Н	No diagnosis
Overload	Н	Н	Н	OUT=H: $V_{\text{OUT}} > V_{\text{OUTSC}}$; Short circuit detection voltage; typ 2.8V
Overtemperature	L	L	Н	No diagnosis
Overtemperature	Н	L	L	
Open load in OFF state	L	Н	L	
Open load in OFF state	Н	Н	Н	No diagnosis



6.3 **Special feature description**

Supply over voltage:

ITS4300S-SJ-D 5-8 \mathbf{Z}_{L}

If over-voltage is applied to the V_S-Pin:

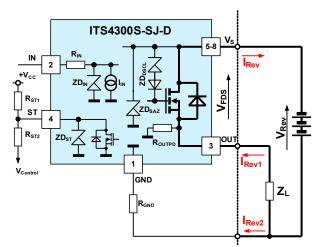
Voltage is limited to V_{ZDSAZ}; current can be calculated:

 $I_{ZDSAZ} = (V_S - V_{ZDSAZ}) / R_{GND}$

A typical value for RGND is 150Ω .

In case of ESD pulse on the input pin there is in both polarities a peak current I_{INpeak} ~ V_{ESD} / R_{IN}

Supply reverse voltage:



If reverse voltage is applied to the device:

1.) Current via load resistance RL:

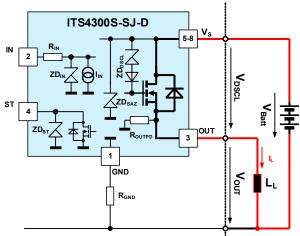
 $I_{Rev1} = (V_{Rev} - V_{FDS}) / R_L$

2.) Current via Input pin IN and dignostic pin ST:

 $I_{Rev2} = I_{ST} + I_{IN} \sim (V_{Rev} - V_{CC})/R_{IN} + (V_{Rev} - V_{CC})/R_{ST1,2}$ Current I_{ST} must be limited with the extrernal series resistor R_{STS}. Both currents will sum up to:

 $I_{Rev} = I_{Rev1} + I_{Rev2}$

Drain-Source power stage clamper V_{DSCL}:

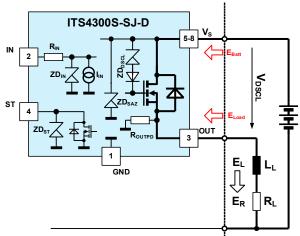


When an inductive load is switched off a current path must be established until the current is sloped down to zero (all energy removed from the inductive load). For that purpose the series combination $Z_{\mbox{\scriptsize DSCL}}$ is connected between Gate and Drain of the power DMOS acting as an active clamp.

When the device is switched off, the voltage at OUT turns negative until V_{DSCL} is reached.

The voltage on the inductive load is the difference between V_{DSCL} and V_{S} .

Energy calculation:



Energy stored in the load inductance is given by: $E_L = I_L^{2*} L/2$

While demagnetizing the load inductance the energy dissipated by the Power-DMOS is:

 $E_{AS} = E_S + E_L - E_R$

With an approximate solution for $R_L = 0\Omega$:

 $E_{AS} = \frac{1}{2} * L * I_{L^2} * \{ (1 - V_S / (V_S - V_{DSCL}) \}$

Figure 5 **Special feature description**



Typical application waveforms 6.4

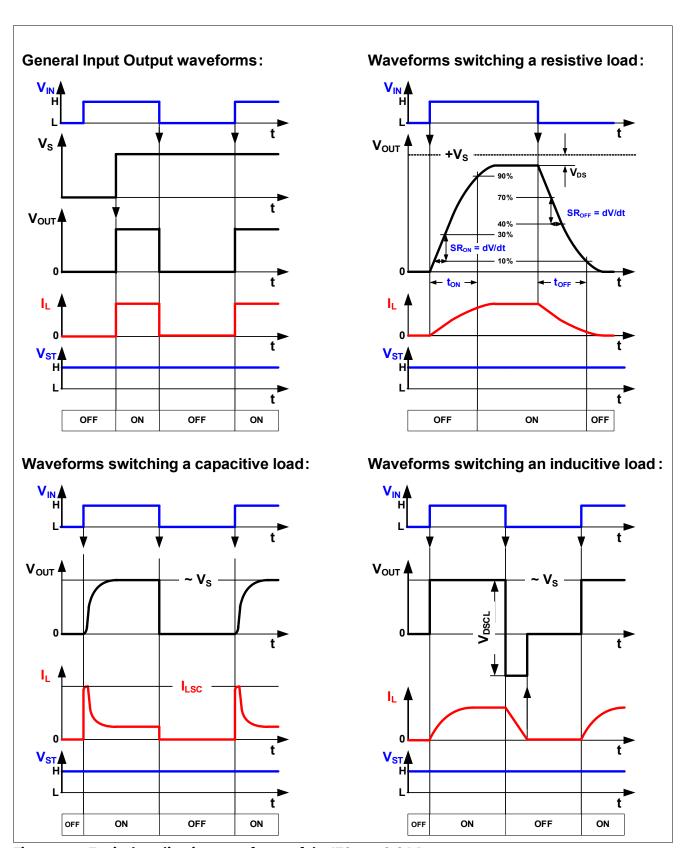


Figure 6 Typical application waveforms of the ITS4300S-SJ-D

Protection behavior 6.5

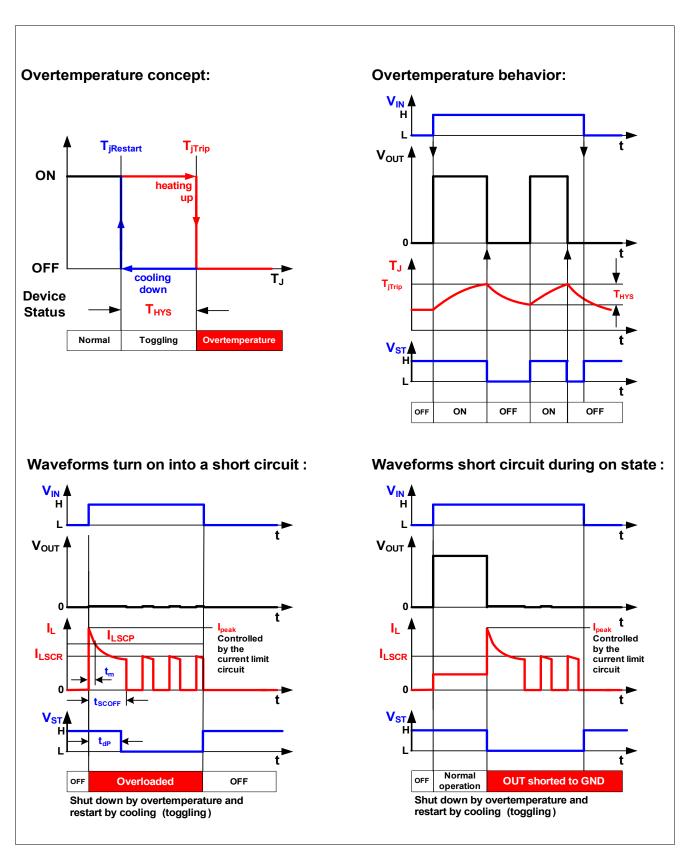


Figure 7 Protective behavior of the ITS4300S-SJ-D

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Package information

7 Package information

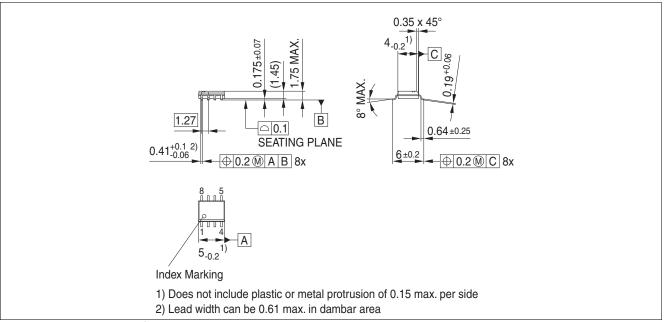


Figure 8 PG-DSO-8¹⁾

Green Product (RoHS compliant)

To meet the world-wide customer requirements for environmentally friendly products and to be compliant with government regulations the device is available as a green product. Green products are RoHS-Compliant (i.e Pb-free finish on leads and suitable for Pb-free soldering according to IPC/JEDEC J-STD-020).

Further information on packages

https://www.infineon.com/packages



Revision history

Revision history 8

Revision	Date	Changes
1.1	2019-07-25	Datasheet updated: - ESD ratings for HBM updated according to ANSI/ESDA/JEDEC JS-001 - Editorial changes
1.0	12-09-01	Datasheet release

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